IN THE CLAIMS

This listing of claims replaces all prior listings:

(Currently Amended) A method of manufacturing a semiconductor device including a laser chip and a base having the laser chip mounted thereon, including the step of:
 providing an assembly with the laser chip mounted on the base; and

irradiating the <u>laser chip and</u> base with an energy beam having a shorter wavelength than an oscillation wavelength of the laser chip to remove adherent from the laser chip and the base.

2. (Currently Amended) A method of manufacturing a semiconductor device according to claim 1 including the step of:

shutting offsealing the base from the outside, after the step of irradiating the laser chip and the base with the energy beam.

- 3. (Original) A method of manufacturing a semiconductor device according to claim 1, wherein a laser chip having a nitride semiconductor layer is used as the laser chip.
- 4. (Original) A method of manufacturing a semiconductor device according to claim 1, wherein a laser chip having an oscillation wavelength of 550 nm or less is used as the laser chip.
- 5. (Original) A method of manufacturing a semiconductor device according to claim 1, wherein irradiation takes place using laser light or ultraviolet light as the energy beam.
- 6. (Original) A method of manufacturing a semiconductor device including a laser chip and a base, including the step of:

irradiating the base having the laser chip mounted thereon with plasma.

7. (Currently Amended) A method of manufacturing a semiconductor device according to claim 6 including the step of:

shutting offsealing the base from the outside, after the step of irradiating the base with the plasma.

- 8. (Original) A method of manufacturing a semiconductor device according to claim 6, wherein a laser chip having a nitride semiconductor layer is used as the laser chip.
- 9. (Original) A method of manufacturing a semiconductor device according to claim 6, wherein a laser chip having an oscillation wavelength of 550 nm or less is used as the laser chip.
- 10. (Original) A method of manufacturing a semiconductor device according to claim 6, wherein the step of irradiating the base with the plasma takes place in an atmosphere of oxygen.